

DS25BR110 3.125 Gbps LVDS Buffer with Receive Equalization

Check for Samples: DS25BR110

FEATURES

- DC 3.125 Gbps Low Jitter, High Noise Immunity, Low Power Operation
- Four Levels of Receive Equalization Reduce ISI Jitter
- On-Chip 100Ω Input and Output Termination Minimizes Insertion and Return Losses, Reduces Component Count, and Minimizes Board Space
- 7 kV ESD on LVDS I/O Pins Protects Adjoining Components
- Small 3 mm x 3 mm 8-WSON Space Saving Package

APPLICATIONS

- Clock and Data Buffering
- Metallic Cable Equalization
- FR-4 Equalization

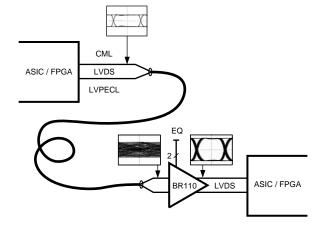
DESCRIPTION

The DS25BR110 is a single channel 3.125 Gbps LVDS buffer optimized for high-speed signal transmission over lossy FR-4 printed circuit board backplanes and balanced metallic cables. A fully differential signal path ensures exceptional signal integrity and noise immunity.

The DS25BR110 features four levels of receive equalization (EQ), making it ideal for use as a receiver device. Other LVDS devices with similar IO characteristics include the following products. The DS25BR120 features four levels of pre-emphasis for use as an optimized driver device, while the DS25BR100 features both pre-emphasis and equalization for use as an optimized repeater device. The DS25BR150 is a buffer/repeater with the lowest power consumption and does not feature transmit pre-emphasis nor receive equalization.

Wide input common mode range allows the receiver to accept signals with LVDS, CML and LVPECL levels; the output levels are LVDS. A very small package footprint requires minimal space on the board while the flow-through pinout allows easy board layout. The differential inputs and outputs are internally terminated with a 100Ω resistor to lower device input and output return losses, reduce component count, and further minimize board space.

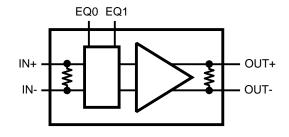
Typical Application



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Block Diagram



Pin Diagram

| EQ0 | [1] | | 8 | VCC |
|-----|-----|-----|---|------|
| IN+ | 2 | DAP | 7 | OUT+ |
| IN- | 3 | GND | 6 | OUT- |
| EQ1 | [4] | | 5 | NC |
| | - | | • | |

Pin Descriptions

| | Pin | Turne | Description | | |
|------|--------|--------|-----------------------------------|--|--|
| Name | Number | Туре | Description | | |
| EQ0 | 1 | Input | Equalizer select pin. | | |
| IN+ | 2 | Input | Non-inverting LVDS input pin. | | |
| IN- | 3 | Input | Inverting LVDS input pin. | | |
| EQ1 | 4 | Input | Equalizer select pin. | | |
| NC | 5 | NA | "NO CONNECT" pin. | | |
| OUT- | 6 | Output | Inverting LVDS output pin. | | |
| OUT+ | 7 | Output | Non-inverting LVDS Output pin. | | |
| VCC | 8 | Power | Power supply pin. | | |
| GND | DAP | Power | Ground pad (DAP - die attach pad) | | |

Control Pins (EQ0 and EQ1) Truth Tables

| EQ1 | EQ0 | Equalization Level | | |
|-----|------------------------------------|-----------------------------------|--|--|
| 0 | 0 | Off | | |
| 0 | 0 1 Low (Approx. 4 dB at 1.56 GHz) | | | |
| 1 | 0 | Medium (Approx. 8 dB at 1.56 GHz) | | |
| 1 | 1 | High (Approx. 16 dB at 1.56 GHz) | | |



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



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Absolute Maximum Ratings⁽¹⁾⁽²⁾

| Supply Voltage (V _{CC}) | | -0.3V to +4V | | | |
|---|-------------------------|-----------------------------------|--|--|--|
| LVCMOS Input Voltage (EQ0, EQ1) | | -0.3V to (V _{CC} + 0.3V) | | | |
| LVDS Input Voltage (IN+, IN-) | | -0.3V to +4V | | | |
| Differential Input Voltage VID | | 1.0V | | | |
| LVDS Output Voltage (OUT+, OUT-) | | -0.3V to (V _{CC} + 0.3V) | | | |
| LVDS Differential Output Voltage ((OUT+) | - (OUT–)) | 0V to 1.0V | | | |
| LVDS Output Short Circuit Current Duratio | 5 ms | | | | |
| Junction Temperature | +150° | | | | |
| Storage Temperature Range | | −65°C to +150°C | | | |
| Lead Temperature Range | Soldering (4 sec.) | +260°C | | | |
| Maximum Package Power Dissipation at | NGQ0008A Package | 2.08W | | | |
| 25°C | Derate NGQ0008A Package | 16.7 mW/°C above +25°C | | | |
| Package Thermal Resistance | θ _{JA} | +60.0°C/W | | | |
| | θ _{JC} | +12.3°C/W | | | |
| | HBM ⁽³⁾ | ≥7 kV | | | |
| ESD Susceptibility | MM ⁽⁴⁾ | ≥250V | | | |
| | CDM ⁽⁵⁾ | ≥1250\ | | | |

(1) "Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. The Recommended Operating Conditions indicate conditions at which the device is functional and the device should not be operated beyond such conditions.

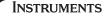
If Military/Aerospace specified devices are required, please contact the TI Sales Office/Distributors for availability and specifications. Human Body Model, applicable std. JESD22-A114C (2)

(3) Machine Model, applicable std. JESD22-A115-A (4)

(5) Field Induced Charge Device Model, applicable std. JESD22-C101-C

Recommended Operating Conditions

| | Min | Тур | Max | Units |
|--|-----|-----|-----|-------|
| Supply Voltage (V _{CC}) | 3.0 | 3.3 | 3.6 | V |
| Receiver Differential Input Voltage (VID) | | | 1.0 | V |
| Operating Free Air Temperature (T _A) | -40 | +25 | +85 | °C |



XAS

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DC Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified. (1)(2)(3)

| | Parameter | Test Conditions | Min | Тур | Max | Units |
|------------------|--|--|------|------|---------------------------|-------|
| LVCMO | DS INPUT DC SPECIFICATIONS (EQ0, EQ1) | | | | | |
| VIH | High Level Input Voltage | | 2.0 | | V _{CC} | V |
| VIL | Low Level Input Voltage | | GND | | 0.8 | V |
| I _{IH} | High Level Input Current | V _{IN} = 3.6V V _{CC} = 3.6V | | 0 | ±10 | μA |
| I _{IL} | Low Level Input Current | $V_{IN} = GND$ $V_{CC} = 3.6V$ | | 0 | ±10 | μA |
| V _{CL} | Input Clamp Voltage | $I_{CL} = -18 \text{ mA}, V_{CC} = 0 \text{V}$ | | -0.9 | -1.5 | V |
| LVDS | OUTPUT DC SPECIFICATIONS (OUT+, OUT-) | | | | | |
| V _{OD} | Differential Output Voltage | | 250 | 350 | 450 | mV |
| ΔV_{OD} | Change in Magnitude of V _{OD} for Complimentary Output States | R _L = 100Ω | -35 | | 35 | mV |
| V _{OS} | Offset Voltage | | 1.05 | 1.2 | 1.375 | V |
| ΔV _{OS} | Change in Magnitude of V _{OS} for Complimentary Output States | R _L = 100Ω | -35 | | 35 | mV |
| l _{os} | Output Short Circuit Current ⁽⁴⁾ | OUT to GND | | -35 | -55 | mA |
| | | OUT to V _{CC} | | 7 | 55 | mA |
| C _{OUT} | Output Capacitance | Any LVDS Output Pin to GND | | 1.2 | | pF |
| R _{OUT} | Output Termination Resistor | Between OUT+ and OUT- | | 100 | | Ω |
| | NPUT DC SPECIFICATIONS (IN+, IN-) | | | | | |
| V _{ID} | Input Differential Voltage | | 0 | | 1 | V |
| V _{TH} | Differential Input High Threshold | V_{CM} = +0.05V or V_{CC} -0.05V | | 0 | +100 | mV |
| V _{TL} | Differential Input Low Threshold | | -100 | 0 | | mV |
| V _{CMR} | Common Mode Voltage Range | V _{ID} = 100 mV | 0.05 | | V _{CC} - 0.05 | V |
| I _{IN} | Input Current | V _{IN} = 3.6V or 0V V _{CC} = 3.6V or 0V | | ±1 | ±10 | μA |
| CIN | Input Capacitance | Any LVDS Input Pin to GND | | 1.7 | | pF |
| R _{IN} | Input Termination Resistor | Between IN+ and IN- | | 100 | | Ω |
| SUPPL | Y CURRENT | | | | | |
| I _{CC} | Supply Current | EQ0 = 0, EQ1 = 0 | | 35 | 43 | mA |

(1) The Electrical Characteristics tables list ensured specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or notes. Typical specifications are estimations only and are not ensured

(2) Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except V_{OD} and ΔV_{OD} .

(3) Typical values represent most likely parametric norms for $V_{CC} = +3.3V$ and $T_A = +25^{\circ}C$, and at the Recommended Operation Conditions at the time of product characterization and are not ensured

(4) Output short circuit current (I_{OS}) is specified as magnitude only, minus sign indicates direction only.



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AC Electrical Characteristics⁽¹⁾

Over recommended operating supply and temperature ranges unless otherwise specified. (2) (3)

| | Parameter | Test Cor | Min | Тур | Max | Units | |
|-------------------|--|---|-------------------|-----|------|-------|-------------------|
| LVDS | OUTPUT AC SPECIFICATIONS (OUT+, OUT-) | | | | | | |
| t _{PHLD} | Differential Propagation Delay High to Low | D 1000 | | | 350 | 465 | ps |
| t _{PLHD} | Differential Propagation Delay Low to High | R _L = 100Ω | $R_L = 100\Omega$ | | | 465 | ps |
| t _{SKD1} | Pulse Skew t _{PLHD} - t _{PHLD} ⁽⁴⁾ | | | | | 100 | ps |
| t _{SKD2} | Part to Part Skew ⁽⁵⁾ | | | | 45 | 150 | ps |
| t _{LHT} | Rise Time | D 1000 | | | 80 | 150 | ps |
| t _{HLT} | Fall Time | R _L = 100Ω | | | 80 | 150 | ps |
| JITTEF | R PERFORMANCE WITH EQ = OFF | | | | | | _ |
| t _{RJ1A} | | V _{ID} = 350 mV | 2.5 Gbps | | 0.5 | 1 | ps |
| t _{RJ2A} | Random Jitter (RMS Value) No Test Channels ⁽⁶⁾ | $V_{CM} = 1.2V$ Clock (RZ) EQ0 = 0, EQ1 = 0 | 3.125 Gbps | | 0.5 | 1 | ps |
| t _{DJ1A} | | V _{ID} = 350 mV | 2.5 Gbps | | 11 | 40 | ps |
| t _{DJ2A} | Deterministic Jitter (Peak to Peak) No Test Channels ⁽⁷⁾ | V _{CM} = 1.2V K28.5 (NRZ) EQ0 = 0, EQ1 = 0 | 3.125 Gbps | | 11 | 47 | ps |
| t _{TJ1A} | | V _{ID} = 350 mV | 2.5 Gbps | | 0.05 | 0.16 | UI _{P-P} |
| t _{TJ2A} | Total Jitter (Peak to Peak) No Test Channels ⁽⁸⁾ | V _{CM} = 1.2V PRBS-23 (NRZ) EQ0 = 0, EQ1 = 0 | 3.125 Gbps | | 0.08 | 0.20 | UI _{P-P} |
| JITTER | R PERFORMANCE WITH EQ = LOW (Figure 5 and | | | | | | |
| t _{RJ1B} | | V _{ID} = 350 mV | 2.5 Gbps | | 0.5 | 1 | ps |
| t _{RJ2B} | Random Jitter (RMS Value) Test Channel D ⁽⁶⁾ | $V_{CM} = 1.2V$ Clock (RZ) EQ0 = 1, EQ1 = 0 | 3.125 Gbps | | 0.5 | 1 | ps |
| t _{DJ1B} | | V _{ID} = 350 mV | 2.5 Gbps | | 1 | 16 | ps |
| t _{DJ2B} | Deterministic Jitter (Peak to Peak) Test Channel D ⁽⁷⁾ | V _{CM} = 1.2V K28.5 (NRZ) EQ0 = 1, EQ1 = 0 | 3.125 Gbps | | 11 | 31 | ps |
| t _{TJ1B} | | V _{ID} = 350 mV | 2.5 Gbps | | 0.03 | 0.09 | UI _{P-P} |
| t _{TJ2B} | Total Jitter (Peak to Peak) Test Channel D ⁽⁸⁾ | V _{CM} = 1.2V PRBS-23 (NRZ) EQ0 = 1, EQ1 = 0 | 3.125 Gbps | | 0.06 | 0.14 | UI _{P-P} |
| JITTER | R PERFORMANCE WITH EQ = MEDIUM (Figure 5 | and Figure 6) | | | | | _ |
| t _{RJ1C} | | V _{ID} = 350 mV | 2.5 Gbps | | 0.5 | 1 | ps |
| t _{RJ2C} | Random Jitter (RMS Value) Test Channel E ⁽⁶⁾ | V _{CM} = 1.2V Clock (RZ) EQ0 = 0, EQ1 = 1 | 3.125 Gbps | | 0.5 | 1 | ps |
| t _{DJ1C} | | V _{ID} = 350 mV | 2.5 Gbps | | 10 | 29 | ps |
| t _{DJ2C} | Deterministic Jitter (Peak to Peak) Test Channel E ⁽⁷⁾ | V _{CM} = 1.2V K28.5 (NRZ) EQ0 = 0, EQ1 = 1 | 3.125 Gbps | | 27 | 43 | ps |

(1) Specification is ensured by characterization and is not tested in production.

(2) The Electrical Characteristics tables list ensured specifications under the listed Recommended Operating Conditions except as

otherwise modified or specified by the Electrical Characteristics Conditions and/or notes. Typical specifications are estimations only and are not ensured

(3) Typical values represent most likely parametric norms for $V_{CC} = +3.3V$ and $T_A = +25^{\circ}C$, and at the Recommended Operation Conditions at the time of product characterization and are not ensured

(4) t_{SKD1}, |t_{PLHD} - t_{PHLD}|, is the magnitude difference in differential propagation delay time between the positive going edge and the negative going edge of the same channel.

(5) t_{SKD2} , Part to Part Skew, is defined as the difference between the minimum and maximum specified differential propagation delays. This specification applies to devices at the same V_{CC} and within 5°C of each other within the operating temperature range.

(6) Measured on a clock edge with a histogram and an accumulation of 1500 histogram hits. Input stimulus jitter is subtracted geometrically.
(7) Tested with a combination of the 1100000101 (K28.5+ character) and 0011111010 (K28.5- character) patterns. Input stimulus jitter is subtracted algebraically.

(8) Measured on an eye diagram with a histogram and an accumulation of 3500 histogram hits. Input stimulus jitter is subtracted.

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AC Electrical Characteristics⁽¹⁾ (continued)

Over recommended operating supply and temperature ranges unless otherwise specified.⁽²⁾⁽³⁾

| | Parameter | Test Cor | Test Conditions | | | | |
|-------------------|--|---|-----------------|--|------|------|-------------------|
| t _{TJ1C} | | V _{ID} = 350 mV 2.5 Gbps | | | 0.07 | 0.12 | UI _{P-P} |
| t _{TJ2C} | Total Jitter (Peak to Peak) Test Channel E ⁽⁸⁾ | V _{CM} = 1.2V PRBS-23 (NRZ) EQ0 = 0, EQ1 = 1 | 3.125 Gbps | | 0.12 | 0.17 | UI _{P-P} |
| JITTEF | R PERFORMANCE WITH EQ = HIGH (Figure | 5 and Figure 6) | • | | | | |
| t _{RJ1D} | | V _{ID} = 350 mV | 2.5 Gbps | | 1.6 | 2.1 | ps |
| t _{RJ2D} | Random Jitter (RMS Value) Test Channel F ⁽⁶⁾ | V _{CM} = 1.2V Clock (RZ) EQ0 = 1, EQ1 = 1 | 3.125 Gbps | | 1.7 | 2.3 | ps |
| t _{DJ1D} | | V _{ID} = 350 mV | 2.5 Gbps | | 30 | 45 | ps |
| t _{DJ2D} | Deterministic Jitter (Peak to Peak) Test Channel F ⁽⁷⁾ | V _{CM} = 1.2V K28.5 (NRZ) EQ0 = 1, EQ1 = 1 | 3.125 Gbps | | 43 | 59 | ps |
| t _{TJ1D} | | V _{ID} = 350 mV | 2.5 Gbps | | 0.14 | 0.27 | UI _{P-P} |
| t _{TJ2D} | Total Jitter (Peak to Peak) Test Channel F ⁽⁸⁾ | V _{CM} = 1.2V PRBS-23 (NRZ) EQ0 = 1, EQ1 = 1 | 3.125 Gbps | | 0.19 | 0.28 | UI _{P-P} |



DC TEST CIRCUITS

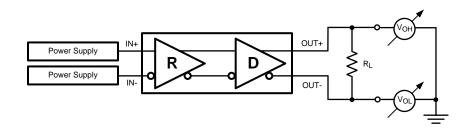


Figure 1. Differential Driver DC Test Circuit

AC Test Circuits and Timing Diagrams

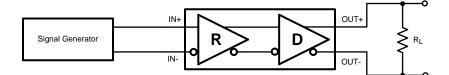


Figure 2. Differential Driver AC Test Circuit

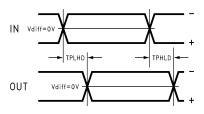


Figure 3. Propagation Delay Timing Diagram

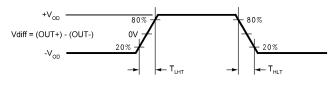
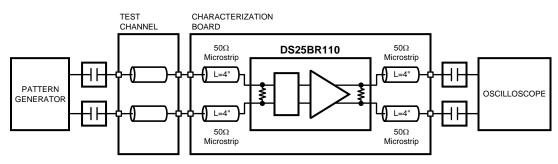
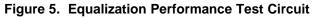


Figure 4. LVDS Output Transition Times

Equalization Test Circuits







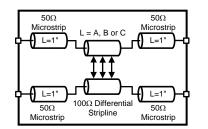


Figure 6. Test Channel Description

Test Channel Loss Characteristics

The test channel was fabricated with Polyclad PCL-FR-370-Laminate/PCL-FRP-370 Prepreg materials (Dielectric constant of 3.7 and Loss Tangent of 0.02). The edge coupled differential striplines have the following geometries: Trace Width (W) = 5 mils, Gap (S) = 5 mils, Height (B) = 16 mils.

| Test Channel | Length | Insertion Loss (dB) | | | | | | | | | |
|--------------|----------|---------------------|---------|----------|----------|----------|----------|--|--|--|--|
| Test Channel | (inches) | 500 MHz | 750 MHz | 1000 MHz | 1250 MHz | 1500 MHz | 1560 MHz | | | | |
| А | 10 | -1.2 | -1.7 | -2.0 | -2.4 | -2.7 | -2.8 | | | | |
| В | 20 | -2.6 | -3.5 | -4.1 | -4.8 | -5.5 | -5.6 | | | | |
| С | 30 | -4.3 | -5.7 | -7.0 | -8.2 | -9.4 | -9.7 | | | | |
| D | 15 | -1.6 | -2.2 | -2.7 | -3.2 | -3.7 | -3.8 | | | | |
| E | 30 | -3.4 | -4.5 | -5.6 | -6.6 | -7.7 | -7.9 | | | | |
| F | 60 | -7.8 | -10.3 | -12.4 | -14.5 | -16.6 | -17.0 | | | | |

Device Operation

INPUT INTERFACING

The DS25BR110 accepts differential signals and allows simple AC or DC coupling. With a wide common mode range, the DS25BR110 can be DC-coupled with all common differential drivers (i.e., LVPECL, LVDS, CML). The following three figures illustrate typical DC-coupled interface to common differential drivers. Note that the DS25BR110 inputs are internally terminated with a 100Ω resistor.

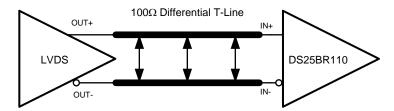
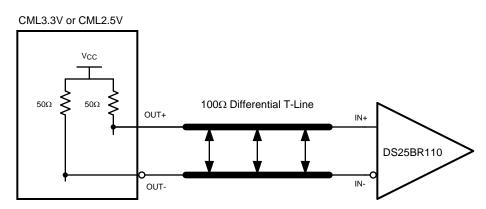
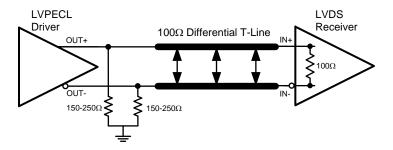


Figure 7. Typical LVDS Driver DC-Coupled Interface to DS25BR110 Input











OUTPUT INTERFACING

The DS25BR110 outputs signals compliant to the LVDS standard. It can be DC-coupled to most common differential receivers. The following figure illustrates typical DC-coupled interface to common differential receivers and assumes that the receivers have high impedance inputs. While most differential receivers have a common mode input range that can accommodate LVDS compliant signals, it is recommended to check the respective receiver's datasheet prior to implementing the suggested interface implementation.

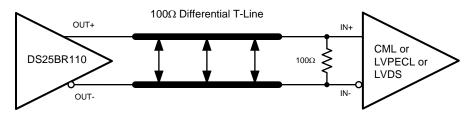
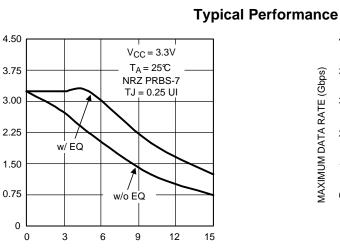


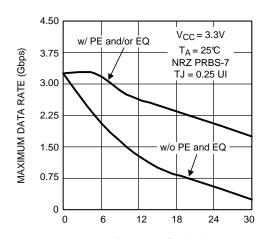
Figure 10. Typical DS25BR110 Output DC-Coupled Interface to an LVDS, CML or LVPECL Receiver

MAXIMUM DATA RATE (Gbps)

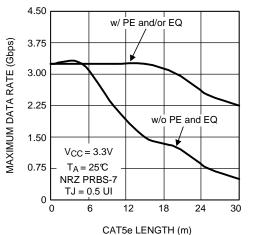
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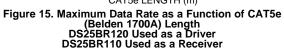


CAT5e LENGTH (m) Figure 11. Maximum Data Rate as a Function of CAT5e (Belden 1700A) Length

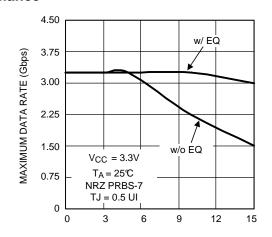




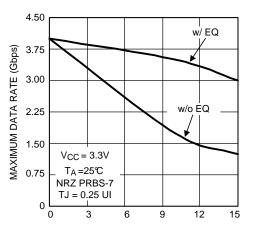




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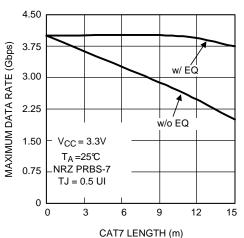


CAT5e LENGTH (m) Figure 12. Maximum Data Rate as a Function of CAT5e (Belden 1700A) Length



CAT7 LENGTH (m)







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Typical Performance (continued)

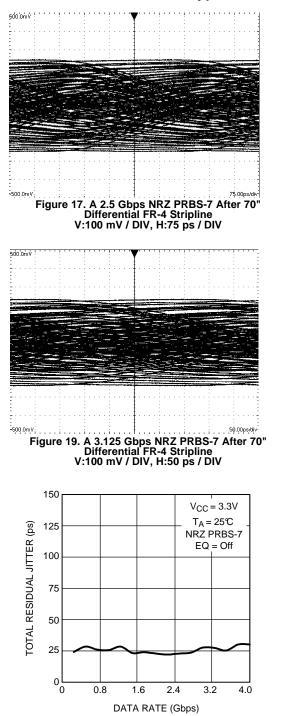


Figure 21. Total Jitter as a Function of Data Rate

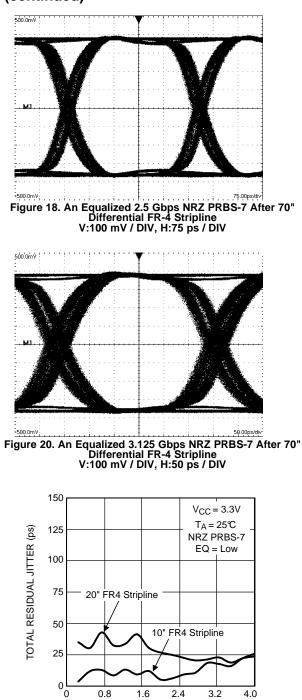


Figure 22. Total Jitter as a Function of Data Rate

DATA RATE (Gbps)

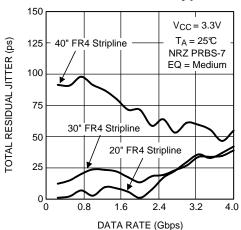
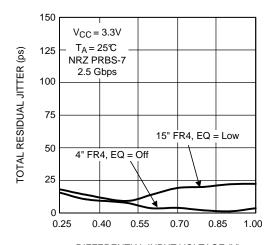


Figure 23. Total Jitter as a Function of Data Rate



DIFFERENTIAL INPUT VOLTAGE (V) Figure 25. Total Jitter as a Function of Input Amplitude

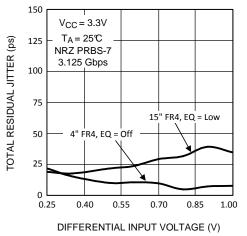


Figure 27. Total Jitter as a Function of Input Amplitude

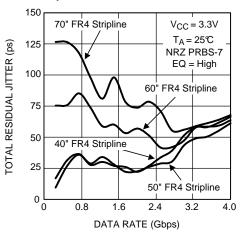


Figure 24. Total Jitter as a Function of Data Rate

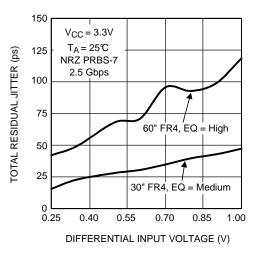
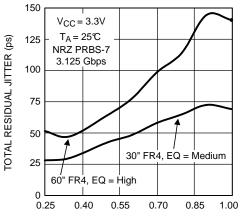


Figure 26. Total Jitter as a Function of Input Amplitude



DIFFERENTIAL INPUT VOLTAGE (V) Figure 28. Total Jitter as a Function of Input Amplitude

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ISTRUMENTS

EXAS

Typical Performance (continued)



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REVISION HISTORY

| Cł | nanges from Revision D (April 2013) to Revision E | Page |
|----|--|------|
| • | Changed layout of National Data Sheet to TI format | 12 |



15-Apr-2013

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package | Pins | Package | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Top-Side Markings | Samples |
|--------------------|--------|--------------|---------|------|---------|----------------------------|------------------|---------------------|--------------|-------------------|---------|
| | (1) | | Drawing | | Qty | (2) | | (3) | | (4) | |
| DS25BR110TSD/NOPB | ACTIVE | WSON | NGQ | 8 | 1000 | Green (RoHS & no Sb/Br) | CU SN | Level-3-260C-168 HR | -40 to 85 | 2R110 | Samples |
| DS25BR110TSDX/NOPB | ACTIVE | WSON | NGQ | 8 | 4500 | Green (RoHS & no Sb/Br) | CU SN | Level-3-260C-168 HR | -40 to 85 | 2R110 | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal | | | | | | | | | | | | |
|-----------------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
| DS25BR110TSD/NOPB | WSON | NGQ | 8 | 1000 | 178.0 | 12.4 | 3.3 | 3.3 | 1.0 | 8.0 | 12.0 | Q1 |
| DS25BR110TSDX/NOPB | WSON | NGQ | 8 | 4500 | 330.0 | 12.4 | 3.3 | 3.3 | 1.0 | 8.0 | 12.0 | Q1 |

TEXAS INSTRUMENTS

www.ti.com

PACKAGE MATERIALS INFORMATION

24-Apr-2013

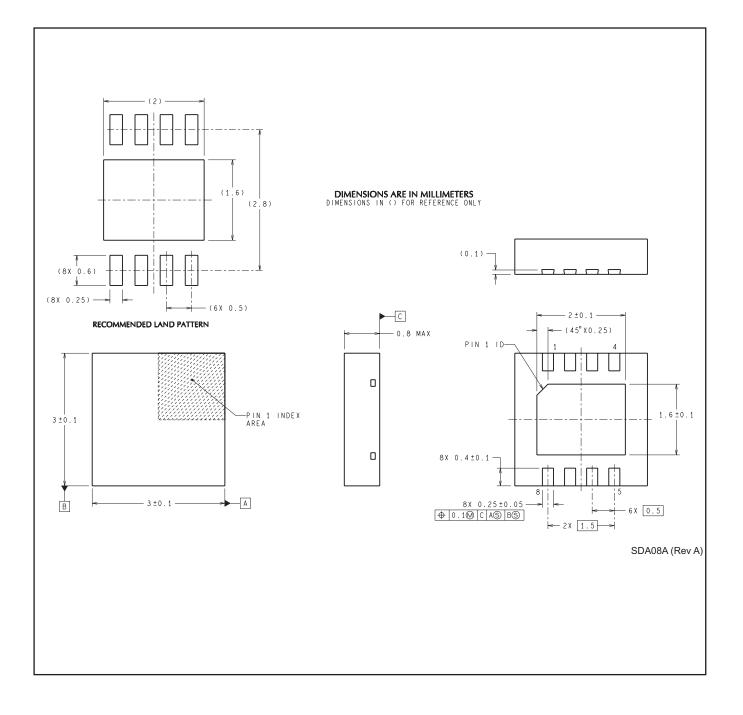


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| DS25BR110TSD/NOPB | WSON | NGQ | 8 | 1000 | 213.0 | 191.0 | 55.0 |
| DS25BR110TSDX/NOPB | WSON | NGQ | 8 | 4500 | 367.0 | 367.0 | 35.0 |

MECHANICAL DATA

NGQ0008A





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